

<b>Notice of References Cited</b>	Application/Control No. 09/768,454	Applicant(s)/Patent Under Reexamination FUKUYOSHI ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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**FOREIGN PATENT DOCUMENTS**

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	N	JP 04275459 A	10-1992	Japan	NAKAI et al.	H01L 27/14
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**NON-PATENT DOCUMENTS**

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